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Resonant photoemission studies of the Kondo-lattice systems CeCu₂Si₂, CeAg₂Si₂, CeAu₂Si₂, and CePd₂Si₂

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Photoemission experiments performed at an incident photon energy of 70 eV provide a clear view of the transition-element-derived d bands in the systems CeT_2Si_2 , with T=Cu, Ag, Au, and Pd. Spectra taken at $h\nu=122$ eV display both a resonant 4f emission at 2-3 eV below E_F , and a resonant emission near E_F . The total intensity of the latter feature, which has been observed in other Ce-based systems and identified as having strong 4f character in γ -cerium and CeAl₂, appears to track the intensities of the transition-element-derived d density of states near E_F . In superconducting CeCu₂Si₂, the E_F feature has its maximum at 0.25 eV, whereas we find it at significantly higher binding energies (~0.6 eV) in the three magnetic systems (T=Ag, Au, and Pd). This observation suggests markedly smaller electronic specific-heat (γ) values in the magnetic compounds as compared with $\gamma \simeq 1$ J mole⁻¹K⁻² generated by heavy fermions in CeCu₂Si₂.

I. INTRODUCTION

The system RT_2Si_2 , where *R* represents a rareearth (RE) ion and *T* a transition- or noble-metal ion, includes a number of important archetypes in the mixed-valence and Kondo-lattice problems. For example, EuPd₂Si₂ is the only Eu-based system reported to exhibit a cooperative valence transition with temperature.^{1,2} The Kondo-lattice system CeCu₂Si₂ is the only system reported to exhibit superconductivity in the presence of (and perhaps because of) heavy fermions generated presumably by interactions between the localized 4f electrons and the conduction electrons.^{3,4} These systems crystallize in the tetragonal ThCr₂Si₂-type structure,⁵ wherein the rare-earth atoms reside on planes well separated by layers of *T* and Si atoms.

Four particular members of the above systems, viz., $CeCu_2Si_2$, $CeAg_2Si_2$, $CeAu_2Si_2$, and $CePd_2Si_2$, were chosen for the present study because of previous characterizations which suggest that the nature of the 4f states and/or their hybridization with band

states might vary significantly within this group. In both⁴ CeCu₂Si₂ and CePd₂Si₂,⁶ for which electrical resistivity measurements exhibit Kondo side-band resonances⁷ and magnetic susceptibility measurements exhibit Curie-Weiss behavior, it appears that the energy of the Kondo-type fluctuations is either larger than or at least comparable to the energy of the cooperative transition, i.e., the onset of superconductivity at $T \sim 0.5$ K in CeCu₂Si₂ and the onset of antiferromagnetism at $T \sim 10$ K in CePd₂Si₂. On the other hand, in CeAg₂Si₂, which appears to undergo a ferrimagnetic transition at $T \sim 8$ K, and CeAu₂Si₂, which undergoes an antiferromagnetic transition at $T \sim 10$ K, there is no definitive evidence for Kondo-type fluctuations above the ordering temperature.⁶

Valence-band photoemission distinguishes itinerant electrons (by probing band structure) and emissions from localized (or quasilocalized) f electrons.⁸ It has proved to be an important tool in the mixed-valence problem.¹ In mixed-valence Sm-, Eu-, Tm-, and Yb-based systems, which are archetypal promotional model systems,⁹ valence-band

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photoemission experiments are capable of yielding directly the mixed-valence quotient of the ground state (see, e.g., Refs. 9 and 10). In these systems, the screened final-hole state $R^{3+}c^{n+1}$ in the photoemission process (where c is a conduction-band electron) is isoenergetic with the initial state $R^{2+}c^n$ as required by the promotional model⁹; therefore, f emission from $R^{2+}c^n$ yields a single spectral feature at E_F . This picture breaks down in Ce-based systems, where the photoemission spectra reveal two spectral features, one which is typically several electron volts from E_F , and one which is near E_F .¹¹ A systematic study of the photoemission in γ -cerium has established the 4f character of both spectral features.¹²

The nature of the 4f state in cerium-based systems, whether the Ce atoms are "mixed valent" (i.e., far from a stable trivalent description) or can be described as forming a Kondo lattice (close to a stable trivalent description) is often difficult to decide.¹³ For instance, it is not clear at this point whether the bimodal structure seen clearly in the valence-band photoemission is γ -cerium (which is weakly mixed valent) is a reflection of the ground state or a result of the photoemission process. Despite this interpretational problem, it is clear from previous studies that valence-band photoemission, particularly if done with variable photon energy as obtained with synchrotron radiation, provides, apart from a view of the valence band, an unmistakable view of the 4f-derived features. The photoemission study reported herein was undertaken to illuminate differences in the 4f character and/or band structures in the Kondo-lattice systems CeT_2Si_2 (with T = Cu, Ag, Au, or Pd). It was hoped that the results of this study might also bring us a step closer to understanding the origin of the bimodal spectrum seen clearly in Ce-based systems which are far from the stable 4f description.

II. EXPERIMENTAL DETAILS

Samples of CeCu₂Si₂, CeAg₂Si₂, CeAu₂Si₂, and CePd₂Si₂ were prepared by arc-melting the pure materials on a water-cooled copper hearth in an argon atmosphere. All of the starting materials were nominally > 99.9% pure or better with respect to metals. The raw materials were melted together and the resulting boule was flipped over and remelted six to eight times. Each sample was then wrapped in tantalum foil, sealed in an evacuated quartz tube, and annealed for four to five days at 800 °C. X-ray diffraction confirmed that the samples were single phase (to within the resolution of the technique, ~5%) with the ThCr₂Si₂ structure. From the boules prepared as above and for use in the photoemission experiments, samples were extracted and shaped into parallelepipeds with approximate dimensions of $4 \times 4 \times 6$ mm.

The photoemission studies were made with the IBM display-type analyzer¹⁴ using synchrotron radiation at the Synchrotron Radiation Center of the University of Wisconsin-Madison. This system was operated in an angle-integrated mode with a total (electrons and photons) energy resolution of ~ 0.15 eV at hv = 70 eV. The sample was first introduced into a preparation chamber (vacuum $\sim 2 \times 10^{-10}$ Torr), where a fresh surface was exposed by fracturing the sample. Following this, the sample was immediately transferred to the measuring position, where the vacuum was better than 10^{-10} Torr. The surface cleanliness, with respect to all important contaminants, was confirmed by Auger spectroscopy and photoemission at low hv to check for hydrogen contamination. In addition, the Si 2p core level was a very sensitive monitor of the surface cleanliness.

III. EXPERIMENTAL RESULTS

A broad view of the photoemission spectra at hv = 70 eV for CeT₂Si₂ (T=Cu, Ag, Au, and Pd) and for the Pd reference system LaPd₂Si₂ is shown in Fig. 1. The intensities of the spectra have been normalized by scaling them according to the peak height of the dominant feature. A visual inspection of the spectra suggests that the alternate procedure of normalizing according to the integrated intensity, i.e., from 0 to 10 eV, would produce similar results. At this photon energy, the spectra are dominated by the T-derived d bands. The general signatures of the dominant spectral features are recognized as d-band emissions by comparing the spectra to those obtained for the corresponding elemental T' metals (Cu, Ag, Au, and Pd; see, e.g., Refs. 15 and 16). The demission features are shifted, relative to the pure Tmetals,^{15,16} by roughly 2 eV to higher binding energies. The cross-hatched regions highlight the spectral region near E_F (0-1 eV), which is expected to mimic the density of states near E_F (if proper account is taken of the relative photoemission cross sections of s, p, and d electrons). The emission in this region is predominantly of T-derived d character, since the s and p electrons have a much smaller photoemission cross section at hv = 70 eV than the d electrons and cannot explain the differences in the intensities at E_F between the spectra.¹⁷ By studying the hv dependence of this part of the spectrum, we can also conclude that these differences are not due to the Ce 5d electrons.¹⁸ We have previously studied the hv dependence of the *d*-band emission in $La_{0.9}Th_{0.1}$, $Ce_{0.9}Th_{0.1}$, and $Pr_{0.9}Th_{0.1}$.¹² Now, we



FIG. 1. Photoemission energy-distribution curves (EDC's) at $h\nu = 70$ eV for Ce T_2 Si₂ (T =Cu, Ag, Au, and Pd) and LaPd₂Si₂ at room temperature. The curves are normalized to maximum emission intensity. The cross-hatched area (0–1 eV) increases in following the sequence Ag, Cu, Au, Pd (see text).

find for the systems presently studied that the Tderived d intensity (taken from the main peak in the spectra) decreases approximately 10 times less as we go from hv = 30 to 70 eV than the RE 5d emission. However, in the RT_2Si_2 systems, the emission close to E_F shows about the same $h\nu$ dependence as the main T-derived d bands. This implies that both these features must be dominated by the T-derived d-band emission, and especially that the Ce 5d contribution to the 70-eV spectra must be very small. Furthermore, since all parts of the RT_2Si_2 spectra in Fig. 1 are dominated by the T-atom d-band emission, the normalized (to the total area of the spectrum) intensity at E_F provides an approximate measure of the partial-T density of states in this region. The Pd-based systems exhibit considerably larger spectral intensity near E_F because of the closeness of the Pd 4d band to E_F . At hv = 122 eV, there is a giant resonance in the Ce4f emission, which was first observed by Johansson et al.¹⁹; hence, a particularly clear view of the Ce4f spectrum can be obtained by



FIG. 2. EDC's for CeCu₂Si₂, CeAg₂Si₂, and CeAu₂Si₂ taken on resonance ($h\nu = 122$ eV, solid line) and off resonance ($h\nu = 112$ eV, dashed line) after normalization to equal intensities for binding energies ≥ 8 eV and background subtraction. The difference curve (dotted line) represents the 4*f* contribution. The arrows indicate the positions of the maximum of the emission feature near E_F .

utilizing this photon energy, as seen in Figs. 2 and 3. The resonance in the Ce4f emission has been identified as resulting from the transition $4d^{10}4f^{1}$ $\rightarrow 4d^{9}4f^{2}$, followed by the Auger decay process $4d^94f^2 \rightarrow 4d^{10}4f^0 + e^-$, the latter process being a so called "super-Coster-Kronig" transition.²⁰ The dominance of the Ce4f emission becomes particularly pronounced for the Ag, Pd, and Au compounds due to the closeness of the energy of the (broad) Cooper minima for the 4d and 5d emissions.²¹ Also shown in Fig. 2 are the spectra recorded at 112 eV, which is an antiresonance for the 4femission (see, e.g., Ref. 22). The 122 and 112 eV spectra are normalized so as to give similar intensities in the energy range above the 4f emission (>4 eV). The 112 eV spectra exhibit emission features which originate from the T metal and Si valence electrons. For all of the compounds except $CeCu_2Si_2$, there is practically zero intensity in the region of the Ce states (0-3 eV). In the case of Cu, the more intense 3d band interferes with the deeper



FIG. 3. Illustration of different subtraction procedures for CePd₂Si₂. Upper panel: On-resonance (hv = 122 eV, solid line) and off-resonance (hv = 112 eV, dashed line) curves produce a difference curve (dotted line) as in Fig. 2. Lower panel: At constant photon energy hv = 122 eV, CePd₂Si₂ (solid line) and LaPd₂Si₂ (dashed line) result in a similar difference spectrum (dotted line) as in the upper panel, indicating negligible variation of the Pd emission for hv = 122 and 112 eV. The arrows indicate the positions of the maximum of the emission feature near E_F .

part of the Ce 4f structure. The *T*- and Si-derived photoemission intensities vary rather slowly with the photon energy, thus also at 122 eV, these contributions are very small (except for the Cu compound in the deeper part of the spectrum).

The peak in the major Ce4f emission occurs at energies ranging from ~ 2.2 eV for CePd₂Si₂ to ~ 2.6 eV for CeAg₂Si₂ for the four systems shown in Figs. 2 and 3. We point out that the location of the *f*-emission peak is not necessarily the location of the 4f level in the ground state as is often suggested or claimed in the literature, but rather, and explicitly, it is the energy required to create a localized, screened 4f hole. As discussed in Sec. I, an additional feature near E_F has been previously observed in the valence-band photoemission spectra of Cebased systems and its f character has been confirmed in the case of γ -cerium.¹² This feature is also clearly present in Figs. 2 and 3 in the spectra recorded at 122 eV. In an attempt to isolate it, we have constructed difference spectra in Figs. 2 and 3. The feature near E_F in the Ce-based systems is clearly resolved in the (122-112)-eV spectra. Note that the appearance of the peak at E_F is not a result of the subtraction procedure, but it is clearly already seen in the 122-eV spectra. An alternate subtraction procedure is exhibited for CePd₂Si₂ in Fig. 3, name-

ly, the subtraction of the spectrum for LaPd₂Si₂ recorded at the same photon energy (122 eV). Again the feature near E_F persists. In order to further concentrate on this feature, in Fig. 4 we have collected all four difference spectra normalized to the total integrated electron-distribution curve (EDC) intensity. This allows a comparison of the intensities of the features near E_F for the different Ce-based systems. It is seen that the intensity of the feature appears to roughly track the intensity of the T-derived d density of states near E_F , the latter depicted by the cross-hatched regions of the 70-eV spectra in Fig. 1. Thus, a comparison of the intensities with the d projection of the density of states near E_F reveals that one has to be cautious before assigning f character to it, for, even in the original work on cerium,¹⁹ it was found that, although f emission is particularly enhanced at the 122-eV resonance, (d-dominated) band emission near E_F was also enhanced at the resonance. This reflects the presence of the auxiliary decay channel $4d^{9}4f^{2}c^{n} \rightarrow 4d^{10}4f^{1}c^{n-1} + e^{-}$, where c represents a conduction-band electron (assumedly of strong d character in the present case) and the final state is a band hole instead of a 4f hole. Therefore, we have to consider the possibility that with either subtraction procedure exhibited in Fig. 3, i.e., 122 - 112 eV or Ce(122 eV) - La(122 eV), the remaining emission near E_F could be dominated by the above resonant band-emission channel. In the case of γ -cerium, it was possible to establish the f



FIG. 4. Difference spectra from Figs. 2 and 3, upper panel, normalized to the total integrated intensity. Note the variation of the emission intensity of the features near E_F and the different peak positions for CeCu₂Si₂ and CeT₂Si₂ (T = Ag, Au, and Pd).

character of the feature observed near E_F not from the spectra recorded in the region of the giant femission resonance but rather by comparing the spectra for γ -cerium, lanthanum, and praseodymium in the photon-energy range 30-70 eV.¹² In the present case, a similar procedure is not possible because the spectra at the lower photon energies (e.g., 30-70 eV) are dominated by T-derived d emission. Instead, we shall discuss the Ce(122 eV)-La(122 eV) subtraction in more detail. The photoabsorption curve for Ce in the vicinity of the 4d ionization threshold shows a region of fine structure (100-115 eV), followed by a giant resonance which has its maximum at hv = 122 eV.²³ Lanthanum has a corresponding giant resonance, but the maximum absorption is already reached at 118 eV.²³ However, these resonance structures are broad and at hv = 122eV, the La absorption is still close to its maximum. We expect the La 5d conduction-band photoemission to track the 5d photoabsorption curve in the same way as the Ce band emission. If the resonating peak closest to E_F in CePd₂Si₂ were due to the Ce 5d conduction-band electrons, we would expect a corresponding peak to appear in the spectrum of LaPd₂Si₂ at the La resonance (as well as at hv = 122eV). As seen from the comparison in Fig. 3, this is not the case. Therefore, we conclude that the peak at E_F in the 122-eV spectrum of CePd₂Si₂ is 4f derived. The low La intensity in Fig. 3 suggests that all the (122-112)-eV difference spectra of Figs. 2 and 3 show the 4f states almost entirely, and, to a much lesser extent, the 5d levels. A similar comparison between U and Th systems was presented in Ref. 24 and showed analogous results.

IV. DISCUSSION

While we could not definitely establish the f character of the anomalous feature near E_F in the present study, it was possible to correlate the intensity of the feature with the T-derived d density of states near E_F . To the extent that the feature near E_F has f character, as it has been established to have in cerium^{11,12} and CeAl₂,²⁵ we can argue that a large d density of states near E_F might have the effect of altering the spatial distribution of the 4f state so as to increase the (negative) f-d hybridization energy. As evident from a comparison of the EDC's for $CeCu_2Si_2$ and CeT_2Si_2 (T = Ag, Au, and Pd) in Figs. 2 and 3, the positions of the peak maxima (indicated by arrows) near E_F are different. In Fig. 4, this observation is even more obvious, and we read 0.25 eV for the maximum in superconducting CeCu₂Si₂, while we find it at significantly higher binding energies ($\sim 0.6 \text{ eV}$) in the three magnetic systems. This could point to a markedly higher density of f states

within the millivolt vicinity of E_F in CeCu₂Si₂ than in the other systems. That we do not get a clearer view is partly due to the limited experimental resolution (≥ 150 meV) and (probably more important) intrinsic relaxation processes of photoemission itself.^{11,12} Accordingly, we expect significantly smaller electronic specific-heat values (yet to be measured) for CeT₂Si₂ (T = Ag, Au, and Pd) than the $\gamma \simeq 1$ J mole⁻¹ K⁻² value attributed⁴ to heavy fermions in CeCu₂Si₂.

The present results, together with previous studies of the magnetic susceptibility and resistivity,^{4,6} suggest that the Ce4f moment in CePd₂Si₂ is unstable as it is in CeCu₂Si₂, yet CePd₂Si₂ orders antiferromagnetically at ~ 10 K, whereas magnetic ordering in CeCu₂Si₂ is inhibited down to ~ 0.5 K, where the system becomes superconducting. Further evidence for the instability of the 4f state in CePd₂Si₂ is provided by recent neutron-diffraction measurements²⁶ on the antiferromagnetic state. The Ce moments are found to be appreciably reduced from their stable values, if one assumes that the crystalfield ground state for CePd₂Si₂ is the same as that identified for $CeCu_2Si_2$.²⁷ On the other hand, neutron-diffraction studies²⁶ of the antiferromagnetic state in CeAu₂Si₂ reveal fully developed Ce moments. We hypothesize that the relative strengths of the moment fluctuations and the magnetic exchange, hence, the ground-state behavior, may depend upon the relative strengths of the T-derived and RE-derived density of states at E_F . Angleresolved valence-band photoemission on this class of materials (in single-crystalline form) in conjunction with band-structure calculations²⁸ will prove very useful in illuminating band-structure details which appear to be highly sensitive to the transitionelement component.

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- ¹Valence Instabilities, edited by P. Wachter and H. Boppart (North-Holland, Amsterdam, 1982).
- ²E. V. Sampathkumaran, R. Vijayaraghavan, K. V. Gopalakrishnan, R. J. Pillay, H. G. Devare, L. C. Gupta, B. Post, and R. D. Parks, in *Valence Fluctuations in Solids*, edited by L. M. Falicov, W. Hanke, and M. P. Maple (North-Holland, Amsterdam, 1981); M. Croft, C. U. Segre, J. A. Hodges, A. Krishnan, V. Murgai, L. C. Gupta, and R. D. Parks, in Ref. 1, p. 121.
- ³F. Steglich, J. Aarts, C. B. Bredl, W. Lieke, D. Meschede, W. Franz, and H. Schäfer, Phys. Rev. Lett. <u>43</u>, 1892 (1979).
- ⁴W. Lieke, U. Rauchschwalbe, C. B. Bredl, F. Steglich, J. Aarts, and F. R. de Boer, J. Appl. Phys. <u>53</u>, 2111 (1982).
- ⁵D. Rossi, R. Marazza, and R. Ferro, J. Less-Common Metals <u>66</u>, 17 (1979).
- ⁶V. Murgai, S. Raaen, L. C. Gupta, and R. D. Parks, in Ref. 1, p. 537.
- ⁷B. Cornut and B. Coqblin, Phys. Rev. B <u>5</u>, 4541 (1972).
- ⁸B. Reihl, N. Mårtensson, P. Heimann, D. E. Eastman, and O. Vogt, Phys. Rev. Lett. <u>46</u>, 1480 (1981).
- ⁹J. M. Lawrence, P. S. Riseborough, and R. D. Parks, Rep. Prog. Phys. <u>44</u>, 1 (1981).
- ¹⁰G. Kaindl, B. Reihl, D. E. Eastman, R. A. Pollak, N. Mårtensson, B. Barbara, T. Penney, and T. S. Plaskett, Solid State Commun. <u>41</u>, 157 (1982).
- ¹¹N. Mårtensson, B. Reihl, and R. D. Parks, Solid State Commun. 41, 573 (1982).
- ¹²R. D. Parks, N. Mårtensson, and B. Reihl, in Ref. 1, p. 239.
- ¹³See numerous papers in Ref. 1.
- ¹⁴D. E. Eastman, J. J. Donelon, N. C. Hien, and F. J. Himpsel, Nucl. Instrum. Methods <u>172</u>, 327 (1980).
- ¹⁵G. K. Wertheim, D. N. E. Buchanan, N. V. Smith, and

M. M. Traum, Phys. Lett. <u>49A</u>, 191 (1974).

- ¹⁶H. Höchst, S. Hüfner, and A. Goldmann, Phys. Lett. A <u>57A</u>, 265 (1976).
- ¹⁷S. M. Goldberg, C. S. Fadley, and S. Kono, J. Electron Spectrosc. <u>21</u>, 285 (1981).
- ¹⁸We are only comparing the $h\nu$ dependence of spectra measured with the same experimental setup. This excludes the need for many otherwise very important corrections.
- ¹⁹L. I. Johansson, J. W. Allen, T. Gustafsson, I. Lindau, and S. B. Hagström, Solid State Commun. <u>28</u>, 53 (1978).
- ²⁰W. Length, F. Lutz, J. Barth, G. Kalkoffen, and C. Kunz, Phys. Rev. Lett. <u>41</u>, 1185 (1978).
- ²¹P. S. Wehner, S. D. Kevan, R. S. Williams, R. F. Davis, and D. A. Shirley, Chem. Phys. Lett. <u>57</u>, 334 (1978).
- ²²A. Franciosi, J. H. Weaver, N. Mårtensson, and M. Croft, Phys. Rev. B <u>24</u>, 3651 (1981).
- ²³S. Suzuki, T. Ishii, and T. Sagawa, J. Phys. Soc. Jpn. <u>38</u>, 156 (1975).
- ²⁴B. Reihl, N. Mårtensson, D. E. Eastman, A. J. Arko, and O. Vogt, Phys. Rev. B <u>26</u>, 1842 (1982).
- ²⁵N. Mårtensson, B. Reihl, V. Murgai, and R. D. Parks (unpublished).
- ²⁶B. H. Grier, J. M. Lawrence, V. Murgai, and R. D. Parks (unpublished).
- ²⁷S. Horn, E. Holland-Moritz, M. Loewenhaupt, F. Steglich, H. Scheuer, A. Benoit, and J. Flouquet, Phys. Rev. B 23, 3171 (1981).
- ²⁸Such band-structure calculations have been performed by J. Kübler (private communication and unpublished) for the La isomorphs. They reveal that the La 5d density of states at E_F tracks to some extent the *T*-derived *d* DOS at E_F .